

**Notice of References Cited**

Application/Control No.

10/587,274

Applicant(s)/Patent Under  
Reexamination  
BODE ET AL.

Examiner

KYUNG J. KIM

Art Unit

3664

Page 1 of 3

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<b>Notice of References Cited</b>	Application/Control No. 10/587,274		Applicant(s)/Patent Under Reexamination BODE ET AL.	
	Examiner KYUNG J. KIM		Art Unit 3664	Page 2 of 3

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Art Unit

3664

Page 3 of 3

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	K	US-			
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